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Substitute for form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary) Sheet 1 of 2	Complete if Known	
	Application Number	10/571183
	Filing Date	03/09/2006
	First named Inventor	James Edmond Bateman
	Group Art Unit	2881
	Examiner name	Vanore
	Attorney Docket Number	063511-9088-00

U.S. Patent Documents

Examiner Initials	U.S. Patent Document Number	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document

FOREIGN PATENT DOCUMENTS

Examiner Initials	Country Code	Foreign Patent Document Number	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document	Translation	English Abstract
/D.V./	WO	9306470	European Economic Community	04/01/1993		

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, pages(s), volume-issue numbers(s), publisher, city and/or country where published.
/D.V./	R. A. ROSENBERG, J. K. SIMONS, and S. P. FRIGO, "X-ray fluorescence detection of low-Z elements using a microchannel plate detector," <i>Review of Scientific Instruments</i> , vol. 63, no. 4, Part 1, April 1992 (1992-04), p. 2193-2194, XP002305295, 1992, American Institute of Physics.

Examiner Signature	/David Vanore/	Date Considered	06/11/2008
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Substitute for form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary) Sheet 2 of 2	Complete if Known	
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	Attorney Docket Number	063511-9088-00
U.S. Patent Documents		

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS		
/D.V./		MASOUD KASRAI ET AL, "X-ray fluorescence measurements of X-ray absorption near edge structure at the Si, P, and S L edges," <i>Journal of Vacuum Science & Technology A (Vacuum, Surfaces, and Films)</i> , vol. 11, no. 5, September-October 1993, p. 2694-2699, XP002305296, ISSN: 0734-2101, p. 2694, right-hand column, p. 2695, right-hand column, paragraph 2, American Vacuum Society, USA.
/D.V./		J. E. BATEMAN ET AL, "Studies of the Gain Properties of Microstrip Gas Counters Relevant to Their Application as X-Ray and Electron Detectors," <i>IEEE Transactions on Nuclear Science</i> , vol. 49, no. 4, August 2002 (2002-08), p. 1644-1650, XP002305297, p. 1649, 2002, IEEE Nuclear and Plasma Sciences Society.
/D.V./		G. TOURILLON ET AL, "Electron yield X-ray absorption spectroscopy at atmospheric pressure," <i>Physics Letters A</i> , vol. 121, no. 5, 27 April 1987, p. 251-257, XP009039581, ISSN: 0375-9601, p. 251 and p. 255, Elsevier Science Publishers B.V., The Netherlands.
/D.V./		M. E. KORDESCH and R. W. HOFFMAN, "Electron-yield extended X-ray absorption fine structure with the use of a gas-flow electron detector," <i>Physical Review B (Condensed Matter) USA</i> , vol. 29, no. 1, January-June 1984, p. 491-492, XP002305299, ISSN: 0163-1829, entire document, The American Physical Society.

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